

Description

The AP3401BI uses advanced Trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = -30V I_{D} = -4.2A$

 $R_{DS(ON)} < 55m\Omega$ @ $V_{GS}=10V$ (Type: 45m Ω)

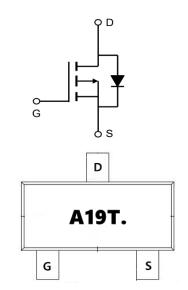
 $R_{DS(ON)} < 68m\Omega$ @ $V_{GS}=4.5V$ (Type: 53m Ω)

Application

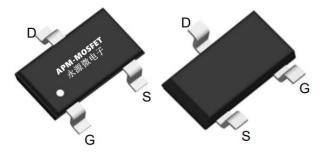
Battery protection

Load switch

Uninterruptible power supply







Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP3401BI	SOT23L	A19T.	3000

Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

Symbol	Parameter	Max.	Units
VDSS	Drain-Source Voltage	-30	V
VGSS	Gate-Source Voltage	±12	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-4.2	A
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-2.7	A
IDM	Pulsed Drain Current note1	-16.8	A
P _D	Power Dissipation T _A = 25°C	1.5	W
R _θ JA	Thermal Resistance Junction-Ambient ¹	125	°C/W
R _θ JC	Thermal Resistance Junction-Case ¹	104	°C/W
TJ, TSTG	Operating and Storage Temperature Range	-55 to +150	°C





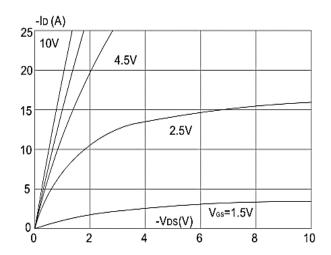
Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	V_{GS} =0V, I_D = -250 μ A	-30	-	-	V
IDSS	Zero Gate Voltage Drain Current	V _{DS} = -30V, V _{GS} =0V,	-	-	-1	μA
IGSS	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±12V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250μA	-0.5	-0.9	-1.5	V
	Static Drain-Source on-Resistance note2	V _{GS} = -10V, I _D = -4A	-	45	55	mΩ
RDS(on)		V _{GS} = -4.5V, I _D = -3A	-	53	68	
		V _{GS} = -2.5V, I _D = -1A	-	72	96	
Ciss	Input Capacitance		-	500	-	pF
Coss	Output Capacitance	V _{DS} = -15V, V _{GS} =0V, f=1.0MHz	-	80	-	pF
Crss	Reverse Transfer Capacitance		-	2	-	pF
Qg	Total Gate Charge		-	8.5	-	nC
Qgs	Gate-Source Charge	V _{DS} = -15V, I _D = -4.2A, V _{GS} = -10V	-	1.8	-	nC
Qgd	Gate-Drain("Miller") Charge	VGS= -10V	-	2.7	-	nC
td(on)	Turn-on Delay Time		-	7	-	ns
tr	Turn-on Rise Time	V _{DD} = -15V, I _D = -1A,	-	3	-	ns
td(off)	Turn-off Delay Time	V_{GS} = -10V, R_{GEN} =2.5 Ω	-	20	-	ns
t _f	Turn-off Fall Time		-	12	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	-4.2	Α
ISM	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-16.8	Α
VSD	Drain to Source Diode Forward Voltage	V _{GS} =0V, I _S = -4.2A	-	-0.8	-1.2	V

Note:

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2 $_{\searrow}$ The data tested by pulsed , pulse width $\,\leqq\,$ 300us , duty cycle $\,\leqq\,$ 2%
- 3. The power dissipation is limited by 150 $^{\circ}\mathrm{C}$ junction temperature
- 4. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.





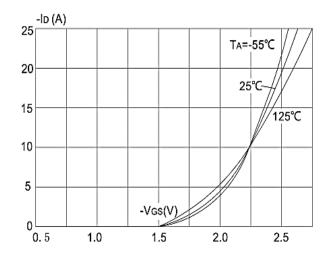


Figure1: Output Characteristics

RDS(ON) (mΩ)

80

60

VGS=-2.5V

VGS=-4.5V

VGS=-10V

20

-ID(A)

0 1 2 3 4 5

Figure 2: Typical Transfer Characteristics

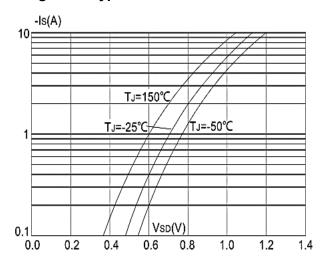


Figure 3:On-resistance vs. Drain Current

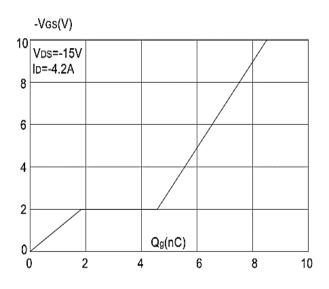


Figure 4: Body Diode Characteristics

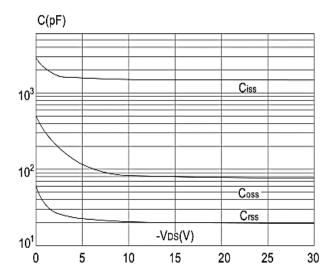


Figure 5: Gate Charge Characteristics

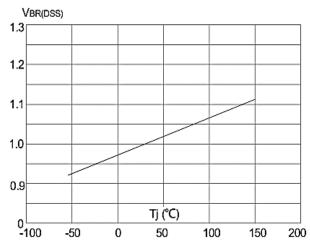
Figure 6: Capacitance Characteristics





Ros(on)

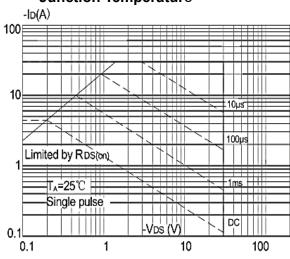
2.5



2.0 1.5 1.0 0.5 -100 -50 0 50 100 150 200

Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

Figure 8: Normalized on Resistance vs. Junction Temperature



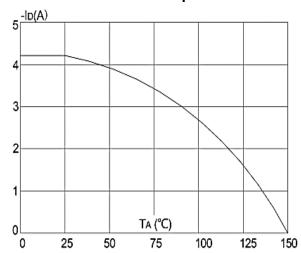


Figure 9: Maximum Safe Operating Area

Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

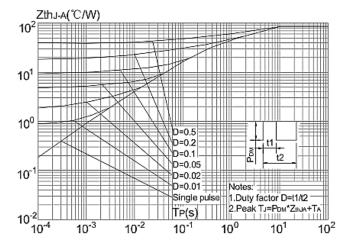
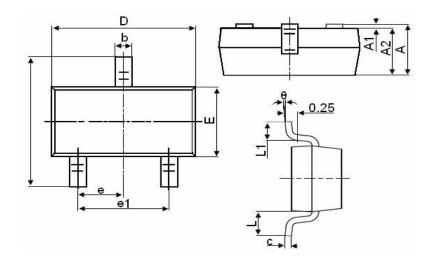


Figure.11: Maximum Effective TransientThermal Impedance, Junction-to-Ambient



Package Mechanical Data-SOT23-XC-Single



Currente e l	Dimensions in Millimeters		
Symbol	MIN.	MAX.	
Α	0.900	1.150	
A1	0.000	0.100	
A2	0.900	1.050	
b	0.300	0.500	
С	0.080	0.150	
D	2.800	3.000	
Е	1.200	1.400	
E1	2.250	2.550	
е	0.950TYP		
e1	1.800	2.000	
L	0.550REF		
L1	0.300	0.500	
θ	0°	8°	



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Edition	Date	Change
Rve1.0	2018/11/31	Initial release
Rve1.1	2021/12/10	Reduce internal RDS

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